

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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| Application No. | : | 10/828360 | Confirmation No. | 4879 |
| Applicant | : | Hiroki Hatajima | | |
| Filed | : | April 20, 2004 | | |
| TC/A.U. | : | 2881 | | |
| Examiner | : | Kalimah Fernandez | | |
| Title | : | "SUBSTRATE TESTING DEVICE AND SUBSTRATE TESTING METHOD" | | |
| Docket No. | : | NGB-15468 | | |
| Customer No. | : | 040854 | | |

INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with Rule 56, applicant is aware of the publications cited in the Korean Office action dated February 24, 2006 in a corresponding Korean patent application. A copy of the Office action and an English translation of the Office action are attached. These publications are listed in the enclosed copy of Patent Office Form PTO/SB/08A. A copy of each of the publications is enclosed herewith.

Respectfully submitted,

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